A Study on Different Spectra in Fault Localization

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Keywords: Fault Localization, Machine Learning, Spectrum, Control Flow, Data Flow, Experimentation.

Abstract: We present an experimental study to assess the impact of different spectra in fault localization. We evaluated one machine learning-based technique (Deep Neural Networks—DNN) and two Spectrum-based fault localization (Ochiai and Tarantula). These techniques were applied on 319 faulty versions of industry-like programs with real bugs using control (statements) and data (definition use associations—DUA) flow coverage as spectra. The results suggest that DNN does not benefit from data flow spectra and any spectrum will generate similar results using either Ochiai or Tarantula. Among the techniques and spectra assessed, Ochiai using control flow seems to be the best choice for fault localization.

1 INTRODUCTION

Debugging is characterized as the task of locating and correcting bugs in programs. It is generally carried out with the help of static information, such as source code and execution reports, as well as dynamic information, such as the state of variables at runtime, obtained through print commands (e.g., *print*) or symbolic debuggers (de Souza et al., 2016).

According to a systematic mapping carried out by Zakari et al. (2018), the most popular technique within this research field is Spectrum-Based Fault Localization (SBFL), being used in 41% of the studies surveyed by the mapping. A program's spectra refers to trace data generated from the execution of the program by a set of tests. SBFL techniques use spectrum data to suggest components (lines, methods, classes) most suspicious of being the site hosting a fault causing an observed failure.

On the other hand, machine learning and data mining techniques have been adopted to facilitate the fault localization task. Wong and Qi (2011) use backpropagation (BP) neural network, statement coverage, and the output (success or fail) of the tests to highlight the most suspicious lines hosting a particular bug.

Recent works extend the use of deep learning models in fault localization (Zhang et al., 2021; Ghosh et al., 2022; Dutta, 2022; Yan et al., 2022; Qian et al., 2023). Such a group of techniques establish what is called Machine Learning-Based Fault Localization (MBFL).

Fault localization techniques make use of coverage data (e.g., statements, branches, definition use associations–DUA) (Rapps and Weyuker, 1985) as spectra to lead the developer towards the most suspicious locations of the program under debugging. However, statement coverage¹ is the most used spectrum for fault localization. The reason for this state of affairs is because tools that collect line coverage are available and are performative (e.g., JaCoCo²). Notwithstanding, there are works that use data flow spectra in fault localization (Santelices et al., 2009; Masri, 2010; Ribeiro et al., 2019).

This paper's goal is to investigate how DUA and line coverage perform when used as spectra supporting MBFL and SBFL. We conducted a study in which one MBFL technique (Deep Neural Network–DNN) and two SBFL techniques (Ochiai and Tarantula) were applied to locate bugs occurring in 319 faulty versions of the Defects4J benchmark (Just et al., 2014).

The organization of the paper is as follows. Basic concepts and the experimental assessment are presented, respectively, in Sections 2 and 3. We present the results in Section 4 and discuss them in Section 5. Related work and the conclusions and future work are discussed, respectively, in Sections 6 and 7.

Hamparsomian, N. and Chaim, M. L. A Study on Different Spectra in Fault Localization. DOI: 10.5220/0013278500003928 Paper published under CC license (CC BY-NC-ND 4.0) In *Proceedings of the 20th International Conference on Evaluation of Novel Approaches to Software Engineering (ENASE 2025)*, pages 492-499 ISBN: 978-989-758-742-9; ISSN: 2184-4895 Proceedings Copyright © 2025 by SCITEPRESS – Science and Technology Publications, Lda.

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¹Despite the differences between the terms line, node and statement, we will interchangeably use them meaning a set of statements executed sequentially.

²https://www.eclemma.org/jacoco/

2 BACKGROUND

We discuss briefly below two SBFL techniques— Tarantula (Jones et al., 2002) and Ochiai (Abreu et al., 2007)—and one MBFL technique—Deep Neural Network (Zheng et al., 2016)—because they will be utilized in our experimental assessment.

2.1 Tarantula and Ochiai

Techniques that use association metrics to rank spectra to pinpoint faulty program components (lines, branches, DUAs, methods, classes) are referred to in this paper as SBFL techniques. These metrics are calculated using coefficients that inform how many times components were, or were not, executed by tests that pass or fail. The more a component is executed by tests that fail, the greater the likelihood of hosting a defect. On the other hand, the less a component is executed by failing tests, the lower its probability of hosting a bug. Thus, the chances of a component being considered suspect are greater when it is often executed by tests that fail and rarely executed by passing tests.

Tarantula is one of the first techniques that utilize association metrics to rank spectra to locate faults. On the other hand, Ochiai is one of the most effective association metrics (Pearson et al., 2017). We refer the reader to the work of de Souza et al. (2016) for the details of how Tarantula and Ochiai rankings are calculated.

2.2 Deep Neural Network

We choose a *Deep Neural Network* (DNN) model as a machine learning-based fault localization technique in our empirical assessment. DNN models are feedforward artificial neural networks containing multiple hidden layers, which is a model capable of estimating the complex non-linear relationships between input and output data. Generally, a DNN model can be used for regression or classification tasks; in this work, it is used as a classification model. However, in order to generate the suspicious values for each code element, the value produced by the output layer was not normalized.

Test case execution spectra and their respective results are are provided as input for training and testing the model. After training, the suspicious rates of the the program elements are calculated for comparison with other fault localization techniques.

3 EXPERIMENTAL ASSESSMENT

This work implements a deep learning model (DNN) as a fault localization (FL) technique trained with control and data flow spectra. The goal is to conduct an empirical evaluation of the rankings produced by DNN and SBFL techniques (Tarantula and Ochiai) obtained with different spectra. The number of source code components to investigate before locating the defect is the main measure of comparison.

In what follows, we discuss the research questions, the deep learning model utilized, the selected faulty programs, the data collection, and how the location of faults was determined. The following experimental design and assessment is similar to that developed by Pearson et al. (2017).

3.1 Research Questions

The main research question investigated by this work is described next:

Do MBFL and SBFL techniques perform better using data flow or control flow spectra?

To answer this main question, we defined the following research sub-questions:

- **RQ1:** Which spectrum produces better rankings for DNN?
 - This question aims to identify, for any given buggy version of a program, which spectrum optimize the accuracy of the DNN model used to locate faults. We applied a set of comparison metrics to assess the spectra ability to locate faults
- **RQ2:** Which spectrum produces better rankings for Tarantula and Ochiai?

The goal of this research question is to identify, for a given faulty version of a program, the spectrum that better position the bug in the ranking for SBFL techniques.

RQ3: Which pair (FL technique, spectrum) achieves the best performance in locating faults?

We also explore the combination of FL technique (SBFL or MBFL) and spectrum (control or data flow) to identify the best approach for fault localization.

3.2 Deep Learning Model

The machine learning technique utilized for fault localization in our experiment is the DNN described in Section 1. The strategies adopted for modeling the DNN and choosing its hyper-parameters will be presented next. The DNN presented in this work was developed based on the guidelines provided in (Zheng et al., 2016; Zhuo et al., 2017).

3.2.1 Modeling the Hidden Layers

After exploratory experiments, we concluded that a fixed value of three hidden layers obtained the best results for the programs present in the Defects4J database. We caution the reader, though, that the the number of layers can be defined using pretraining methods to fine-tune the parameters of the model (Zheng et al., 2016). However, these dynamic strategies would benefit both control and data flow spectra and should not impact the comparison of spectra.

3.2.2 Number of Neurons per Layer

The number of neurons of the input and output layers can be defined directly based on the characteristics of the data provided for training. The number of neurons in the input layer is equal to the total number of executable elements covered (according to the respective spectrum) by the tests. The output layer is composed of a single neuron that represents the result of the test case execution (success or failure).

For the model presented in this work, we a adopted the strategy presented in Zhuo et al. (2017) in which the number of neurons in each hidden layer is defined according to the following formula: quantity = round(n/30 + 1) * 10, where *n* represents the number of neurons of the previous layer.

3.2.3 Activation Functions Modeling

We chose to follow the guidelines provided in Zhuo et al. (2017), in which the model used the function *relu* to activate the hidden layers and the nonlinear activation function *sigmoid* for the result generated in the output layer. Such a parameterization showed the best results during the experimentation carried out for our model. The formulas applied by each of the functions are: relu(x) = max(0,x) and $sigmoid(x) = 1/(1+e^{-x})$, where *x* represents the output vector of the previous layer that will be transformed based on the respective activation function defined for each layer.

3.2.4 Learning Rate Modeling

Zheng et al. (2016) chose manually the learning rate through experimentation for each of the programs explored. On other hand, Zhuo et al. (2017) adopted the strategy to dynamically define the learning rate starting with a high value at the beginning of the training and gradually decreasing the value defined during the training execution according to a pre-defined value of *DropRate*. This way, updating weights during training is more subtle in the final stages of training. We came to the conclusion, after several experiments, that a fixed learning rate value of 0.001 for control flow and 0.01 for data flow obtained the best results for the programs present in the Defects4J database.

3.3 Selection of Faulty Programs

We selected a subset of the Defect4J programs to conduct the experiment with control and data flow spectra. The data used were previously collected by Pearson et al. using GZoltar comprise six programs, namely: Chart, Closure, Lang, Math, Mockito and Time, totaling 395 faulty versions (Pearson et al., 2017).

Nevertheless, not all fault versions of the Defect4J repository could be utilized in our experiment due to Jaguar's limitations to generate data flow spectra. We refer the reader to the site³ of the experiment for the list of discarded versions and the motivations for their removal, as well to the procedures carried out to prepare the data for the experiment.

3.4 Data Collection

In order to be able to conduct evaluations to answer the research questions, we obtained the spectra from the execution of the programs present in the Defects4J *dataset*. To this end, spectra based on control flow (nodes) and data flows (DUAs) were used.

Statement coverage was previously generated by Pearson et al. (2017) using GZoltar⁴ whereas DUA data were previously generated by Silva and Chaim (2021) using Jaguar⁵.

3.5 Fault Localization

From the node and DUA coverage data previously generated, fault localization techniques based on association metrics (Tarantula and Ochiai) and machine learning (DNN) were applied to obtain the suspiciousness rates for each covered line.

In what follows, we present the steps taken to apply the fault localization techniques, namely, identification of defective lines, treatments for multi-defect

⁴fault-localization.cs.washington.edu/data/ ⁵drive.google.com/drive/u/1/folders/

³https://github.com/NicolasHampa/ jaguar-data-flow-experiments

¹ncaRLxUVRsA3RoL0I0VOZRAp4QmIfKTA

scenarios, and the operation of the pipeline to generate rankings for each technique analyzed.

3.5.1 Faulty Lines Identification

As the coverage information generated by Jaguar and GZoltar refers to DUAs and nodes, respectively, we mapped the elements to their respective lines of code. This procedure was performed for each of the buggy versions under analysis in this experiment and will be described below.

A feature of the Defects4J repository is that a defective version for a given program may contain multiple points of change for a fix to take effect. We adopted the strategies of Pearson et al. (2017) to deal with multi-lines defects. These strategies will described as follows.

3.5.2 Suspiciousness Rate Draws

Fault localization techniques first calculate suspiciousness rates (scores) for each of the program elements. The results are ordered in a ranked list containing the analyzed elements. When two or more elements have identical suspiciousness rates, making an arbitrary choice might affect the evaluation of the results. Pearson et al. (2017) handle multiple elements with the same suspiciousness rate as being the *nth* element in the output, where *n* is the average ranking of these elements. We adopted the same approach.

3.5.3 Statements and DUAs Mapped into Lines

To allow a consistent evaluation, all elements (statements or DUAs) were mapped into their respective lines. Thus, fault localization techniques rankings are sorted lists of suspected lines of code, favoring the evaluation of the results obtained for different spectra.

3.5.4 Multi-Line Bugs

Real bugs as those present in the Defects4J repository are spread into several lines of the program. Thus, we need to formally define when a bug is found: Is identifying at least one of the defective lines enough? Or do all faulty lines of the program need to be identified? In this experiment, we only considered *best case* scenarios, due to time limitations. In this scenario, it suffices to identify one faulty line so that the bug can be completely understood and fixed.

3.5.5 Omission Bugs

In 30% of scenarios involving real-world defects, the fix consists of adding new code rather than changing

existing code (Pearson et al., 2017). In other words, the program itself does not contain any element that could be considered the site of the defect: every expression, operation and statement in the program is correct, but elements are missing. For each omission fault, a set of candidate lines that fixes the bug was manually determined. Therefore, an omission bug is deemed localized when any of its candidate lines is present in the list of suspicious lines generated by a particular fault localization technique.

3.5.6 Bugs on Non-Executable Code

In the Defects4J repository, there are real failure scenarios caused partially or completely by bugs present in non-executable portions of code. We discarded versions versions whose all buggy lines are nonexecutable code. We focus in this experiment on versions that actually had at least one defective element covered by spectra generated by GZoltar and Jaguar.

4 **RESULTS**

We used measures already applied in previous FL works, such as Absolute score, FLT rank and TOP-N score. They are briefly explained as follows.

Absolute Score. Determines the absolute position of the defective element present in the ranking produced by the FL technique. **FLT Rank.** For each defective program, the applied FL techniques are ranked from 1 to *n*, with *n* being the total number of techniques under analysis. FLT is the acronym for *Fault Localization Technique*. The FLT rank of a technique represents the relative position of that technique compared to the others (the fewer, the better). **Top-N Score.** Given a previously defined *N* position (1, 5, 10, etc.), this score indicates the percentage of defective versions (provided by the Defects4J dataset) in which the applied FL technique was able to position the defective element in the same position or less than *N*.

Table 1 presents the average FLT rank of all techniques covered in this work. The techniques, presented in column *Technique*, are ordered from the best technique to the worst in column *Pos.*. The *Family* column indicates whether the applied technique is an SBFL or an MLFL technique. The *Spect*. column indicates whether the technique was applied based on control flow (Stmt) or data flow (DUA) spectra. The *Aver*. column represents the average score considering all valid versions of all programs present in the Defects4J *dataset*. The table shows that Ochiai in combination with control flow spectra achieved the best score.

Pos.	Family	Technique	Spect.	Aver.
1	SBFL	Ochiai	Stmt	2.85
2	SBFL	Ochiai	DUA	2.86
3	SBFL	Tarantula	DUA	3.02
4	SBFL	Tarantula	Stmt	3.06
5	MLFL	DNN	Stmt	4.52
6	MLFL	DNN	DUA	4.70

Table 1: Average FLT score for all techniques.

Table 2 presents the results in terms of Top-N score. Columns *Technique*, *Family*, and *Spect*. have the same meaning of those of Table 1. The last three columns indicate the percentage of versions in which the faulty element was ranked among the first 1, 5, and 10 positions of the ranking among all versions. Ochiai using statements and DUAs presented the best results, although it does not differ significantly from Tarantula using statements and DUAs.

Table 3 presents the FLT Rank effect size (Cohen's d) (Bobbitt, 2022) for pair (Ochiai,Stmt) with respect to other pairs of (FL technique, spectrum). Typically, d less than 0.2 represents a *negligible* effect size, less than 0.5 represents a *small* effect size, less than 0.8 represents a *medium* effect size, and greater than or equal to 0.8 represents a *large* effect size.

Regarding the absolute value of the effect size tests for the FLT Rank, (Ochiai, Stmt) has a *negligible* effect size in comparison to (Tarantula, Stmt), (Ochiai, DUA), and (Tarantula, DUA). On the other hand, it has a large effect size with regards to (DNN, stmt) and (DNN, DUA).

Figure 1 presents a density curve containing the distribution of the Absolute score for all faulty versions from Defects4J programs using both control and data flow spectra. The *Density* axis represents the probability of an FL technique assuming a given value. The distribution of values in the graph is presented in logarithmic scale format in terms of absolute number of elements analyzed. The curve shows the density of a continuous random variable distributed on the *x* axis. The lower the scores obtained by a given FL technique, the better the performance of the

Techni-	Fami-	Spect.	Тор	Тор	Тор
que	ly		1	5	10
DNN	MLFL	Stmt	3%	19%	26%
DNN	MLFL	DUA	1%	10%	14%
Ochiai	SBFL	Stmt	3%	30%	41%
Tarantula	SBFL	Stmt	3%	29%	41%
Ochiai	SBFL	DUA	1%	30%	41%
Tarantula	SBFL	DUA	1%	29%	39%

Table 2: Top-N Score.

technique.

5 DISCUSSION

We organize our discussion based on the research questions presented in Section 3. We conclude this section with the discussion of the threats to validity.

5.1 RQ1: Best Spectrum for DNNs?

Rows 5 and 6 of Table 1 show the average FLT Score for DNN using statement (row 5) and DUA (row 6). FLT rank compares a particular technique against the others. DNN using either statement or DUAs ranked poorly against the other techniques; though, DNN with statement performed slightly better in comparison to DNN with DUAs.

The first two rows of Table 2 present the results of Top-1, Top-5 and Top-10 score for DNN techniques. DNN using DUAs performed significantly worst than DNN using statements. The latter approach identifies twice the amount of faults at the Top-5 and Top-10 positions of the ranking and three times more at the Top-1; though, the absolute values (3% against 1%) for this range are quite small.

These results indicating that DNN with statements performs better in the first positions of the ranking is corroborated by Figure 1. One can observe that DNN with statements (full line in red) is significantly better than DNN with DUAs in the first 10 positions comparing with DNN using DUAs (dashed line in red). This situation inverts for higher positions of the ranking.

The average measures of FLT score suggest a draw between control and data flow spectra being used in DNN. However, studies (Parnin and Orso, 2011; de Souza et al., 2024) have shown that developers limit their attention to the first positions of the rankings. Thus, positioning the bug in those positions is pivotal. In this sense, the top-N scores performance suggests that *statement coverage is the best spectrum for fault localization using DNN*.

5.2 RQ2: Best Spectrum for Tarantula and Ochiai?

Considering the average FLT score (Table 1, rows 1 and 2), there is a draw between control and data flow spectra. Ochiai using either statements or DUAs obtains very close averages. Similar averages are obtained by Tarantula using both spectra.

Regarding the Top-N score measures, one can observe that statement coverage obtains better results



Table 3: Effect size for FLT Rank.

Figure 1: Absolute Score density curve for all faulty versions.

for Top-1 score for both Tarantula and Ochiai while there is a draw for Top-5 and Top-10 scores. Though the Top-1 measure indicates a better performance for statement coverage, it implies yet that only 3% of the bugs are located in the first position whereas around 40% of them are located in the first 10 positions. The user studies suggest that a developer will hardly check beyond the 10th position to search for a bug, but it seems also unlikely that s/he will only check the first position.

Figure 1 provides a graphical evidence of the draw between the spectra used by SBFL techniques. The blue and green dotted lines refer to Tarantula and Ochiai, respectively, using statements while the blue and green dashed lines refer to the same techniques using DUAs. Clearly, these lines are very similar almost until the 100th position of the ranking suggesting that *there is no prevalence of a particular spectrum for SBFL techniques*.

5.3 RQ3: Best Pair (FL Technique, Spectrum)?

One valid question is: Which is the best approach for fault localization using spectra? The average FLT scores table suggests that on average DNN, independently of the spectrum, falls behind of SBFL techniques. Figure 1 indicates that the density of faults for DNN techniques located at the first positions of the rankings (until the 10th position) is significantly below the density for Ochiai and Tarantula. Thus, based on our experimental results, Tarantula or Ochiai is a better choice for fault localization than DNN using any spectrum.

Table 3 presents a comparison of the effect size of the pair (Ochiai, statement) FLT rank with respect to the other possible pairs. As expected the effect size for such a metric of (Ochiai, statement) in comparison to DNN techniques is medium or large.

One should bear in mind that the analyses using averages and effect sizes presented in Tables 1 and Table 3 take in account all 319 faulty versions. So it also consider those versions for which (Ochiai, statement) performed better, but positioned the buggy lines in ranking positions that are away of the ten first positions of the rankings.

Despite the indication that there is a draw between spectra for SBFL techniques and the negligible effect size for the FLT rank, if one has to choose a particular approach, the pair (*Ochiai, statement*) seems to be the best choice for fault localization in our experiment.

5.4 Threats to Validity

We address in this section the threats to the internal, external, and conclusion validity. *Threats to internal validity* are related to the several scripts implemented in the different stages of the experimental assessment. This threat might present itself in terms of defects present in the code of the scripts or in an inaccurate conceptual understanding of the FL problem explored.

External validity threats are concerned to the generalization of the results presented. Other sets of programs may obtain different results; nevertheless, a set of six programs was used, written by different developers and focusing on different application areas. Regarding the comparisons between data flow and control flow, 319 defective versions were assessed in total.

Another threat is that our results are only applicable to DNN models. There are other works that utilize deep neural networks (Qian et al., 2021; Li et al., 2021; Ghosh et al., 2022; Dutta, 2022) that achieve better rankings. Also, there are pretraining methods that can enhance the model parametrization (Zheng et al., 2016). Finally, there are strategies for data treatment that are not applied, like more sophisticated representations of the coverage data (Lou et al., 2021)

Conclusion validity threats are related to the metrics utilized to assess the research questions. The FLT rank metric is a way to compare FL techniques directly, rather than just their absolute performance, since this metric is agnostic to whether the metrics being compared are absolute or relative. The Top-N score metric can be better correlated with the developer's ability to debug the code.

We make available all our results obtained to be reproduced by a reader interested in this work. The scripts used are available in the GIT repository⁶.

6 RELATED WORK

In the last few years, we have observed the use of machine learning models based on neural networks and deep learning for fault localization (Zhang et al., 2021; Wong, 2023). Initially, control flow coverage were mostly used together with machine learning techniques for defect localization (Wong and Qi, 2011). Other works, though, have started using spectra based on data flow (Li et al., 2021; Jo et al., 2021; Ren et al., 2022).

Ren et al. (2022), Li et al. (2021), Jo et al. (2021) combine data and control flow spectra to train different machine learning models (radial basis neural network, convolutional neural network, and backpropagation neural network, respectively) for fault localization. Thus, these works focus on the combination of spectra as fault localization techniques, but not in the analysis of the performance of different spectra in MBFL.

On the other hand, in the SBFL realm, previous works have addressed the comparison of different spectra for fault location. Santelices et al. (2009) indicate that DUAs are better than statements and branches when used in SBFL techniques to locate bugs. Masri (2010) points out that DIFA— Dynamic Information Flow Analysis, also a data flow spectrum—, DUA and branch spectra, performed better than statement spectrum. Ribeiro et al. (2019) investigate how data flow coverage, notably, DUA, compares to line coverage. Their results suggest that up to 50% more faults are ranked in the Top-15 positions using data flow spectra in comparison with line spectra.

However, Santelices et al. (2009) and Masri (2010) use few and small (in terms of lines of code)

faulty programs, and, for the most part, containing bugs artificially inserted into the programs. Ribeiro et al. (2019) use 163 faulty versions selected from Defects4J repository, and faulty versions from JSoup's own repository.

Our study experiment with 319 faulty versions from Defects4J's Chart, Closure, Math, Mockito, and Time, and with a MBFL technique (DNN) and two SBFL techniques (Ochiai and Tarantula).

7 CONCLUSIONS

We presented an experiment whose goal was to investigate how control and data flow spectra impact on the performance of fault localization techniques. We experimented with one MBFL (Deep Neural Networks—DNN) and two SBFL (Ochiai and Tarantula) techniques.

Our results suggest that DNN using statement spectra generate more effective rankings in comparison to DNN using DUAs. On the other hand, SBFL techniques like Ochiai and Tarantula do not present a prevalence of either type of spectra, especially when one focus the attention on the first ten positions of the rankings. Finally, we analyzed which pair (fault localization technique, spectrum) performs best in our experiment. (Ochiai, statement) seems to be the best pair, though, the effect sizes are negligible or small with respect to Tarantula using statements or DUAs and Ochiai using DUAs.

We believe our experiment is one more piece of evidence towards a better understanding of the role of spectra in fault localization. We intend to apply the same experimental design for MBFL using convolutional Deep Neural Networs and expand the number and the diversity of faulty programs in further experiments.

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